杰力科技股份有限公司
Excelliance MOS Corporation

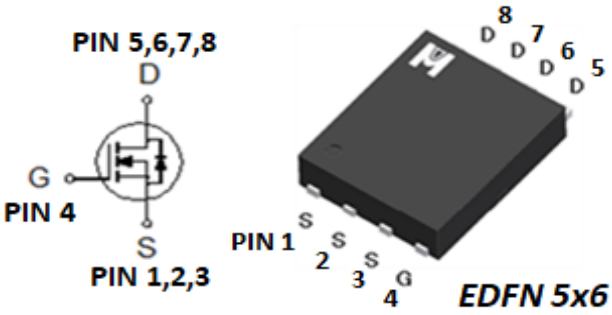
EMB07N03HS

Single N-Channel Logic Level Enhancement Mode Field Effect Transistor

▪Product Summary:

	N-CH
BVDSS	30V
$R_{DSON\ (MAX.)}$@V_{GS}=10V	7.0mΩ
$R_{DSON\ (MAX.)}$@V_{GS}=4.5V	10.6mΩ
I_D @T_C=25°C	51A
I_D @T_A=25°C	14A

▪ Pin Description:



Single N Channel MOSFET
UIS, Rg 100% Tested
RoHS & Halogen Free & TSCA Compliant

▪ABSOLUTE MAXIMUM RATINGS (T_C = 25 °C Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNIT
Gate-Source Voltage		V_{GS}	±20	V
Continuous Drain Current	T_C = 25 °C	I_D	51	A
	T_C = 100 °C		46	
Continuous Drain Current	T_A = 25 °C	I_D	14	
	T_A = 70 °C		11	
Pulsed Drain Current[1]		I_{DM}	110	
Avalanche Current		I_{AS}	30	
Avalanche Energy	L = 0.1mH	EAS	45	mJ
Repetitive Avalanche Energy[2]	L = 0.05mH	EAR	22.5	
Power Dissipation	T_C = 25 °C	P_D	56.8	W
	T_C = 100 °C		22.7	
Power Dissipation	T_A = 25 °C	P_D	2.3	W
	T_A = 70 °C		1.5	
Operating Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 150	°C

▪ 100% UIS testing in condition of VD=25V, L=0.1mH, VG=10V, IL=18A, Rated VDS=30V N-CH

▪THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNIT
Junction-to-Case	$R_{\theta JC}$		2.2	°C/W
Junction-to-Ambient[3]	$R_{\theta JA}$		55	

[1]Pulse width limited by maximum junction temperature.

[2]Duty cycle < 1%

[3]The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C.

[4]Guarantee by Engineering test

▪ ELECTRICAL CHARACTERISTICS (T_J = 25 °C, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage[4]	$V_{(BR)DSS}$	V_{GS} = 0V, I_D = 250μA	30			V
Gate Threshold Voltage[4]	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = 250μA	1.2	1.8	2.5	V
Gate-Body Leakage[4]	I_{GSS}	V_{DS} = 0V, V_{GS} = ±20V			±100	nA
Zero Gate Voltage Drain Current[4]	I_{DSS}	V_{DS} = 30V, V_{GS} = 0V			1	μA
		V_{DS} =30V, V_{GS} =0V, T_J = 125 °C			100	
On-State Drain Current[1]	$I_{D(ON)}$	V_{DS} = 10V, V_{GS} = 10V	51			A
Drain-Source On-State Resistance[1,4]	$R_{DS(ON)}$	V_{GS} = 10V, I_D = 25A		5.9	7	mΩ
		V_{GS} = 4.5V, I_D = 20A		8.9	10.6	
Forward Transconductance[1]	g_{fs}	V_{DS} = 5V, I_D = 25A		18		S
DYNAMIC						
Input Capacitance[5]	C_{iss}	V_{GS} = 0V, V_{DS} = 15V, f = 1MHz		970		pF
Output Capacitance[5]	C_{oss}			428		
Reverse Transfer Capacitance[5]	C_{rss}			46		
Gate Resistance[4,5]	R_g	f = 1MHz		1.3		Ω
Total Gate Charge[1,2,5]	Q_g(V_{GS}=10V)	V_{DS} = 15V, V_{GS} = 10V, I_D = 25A		16.9		nC
	Q_g(V_{GS}=4.5V)			8.5		
Gate-Source Charge[1,2,5]	Q_{gs}			2.6		
Gate-Drain Charge[1,2,5]	Q_{gd}			3.2		
Turn-On Delay Time[1,2,5]	$t_{d(on)}$	V_{DS} = 15V, V_{GS} = 10V, I_D = 5A , Rg = 3Ω		5.6		nS
Rise Time[1,2,5]	t_r			6.8		
Turn-Off Delay Time[1,2,5]	$t_{d(off)}$			13.6		
Fall Time[1,2,5]	t_f			2.9		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS						
Continuous Current	I_S				44	A
Pulsed Current[3]	I_{SM}				110	
Forward Voltage[1,4]	V_{SD}	I_F = 25A, V_{GS} = 0V			1.3	V
Reverse Recovery Time[5]	t_{rr}	I_F = 25A, dI_F/dt = 400A / μS		9.8		nS
Peak Reverse Recovery Current[5]	$I_{RM(REC)}$			1.6		A
Reverse Recovery Charge[5]	Q_{rr}			8.8		nC

[1]Pulse test : Pulse Width ≦ 300 usec, Duty Cycle ≦ 2%.

[2]Independent of operating temperature.

[3]Pulse width limited by maximum junction temperature.

[4]Guarantee by FT test Item

[5]Guarantee by Engineering test

EMC will review datasheet by quarter, and update new version.

▪TYPICAL CHARACTERISTICS

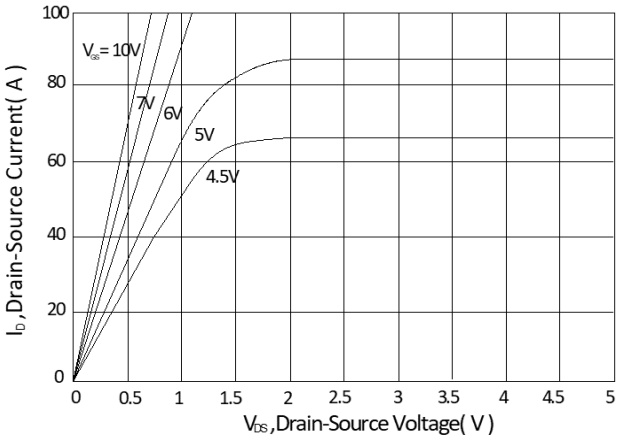


Fig.1 Typical Output Characteristics

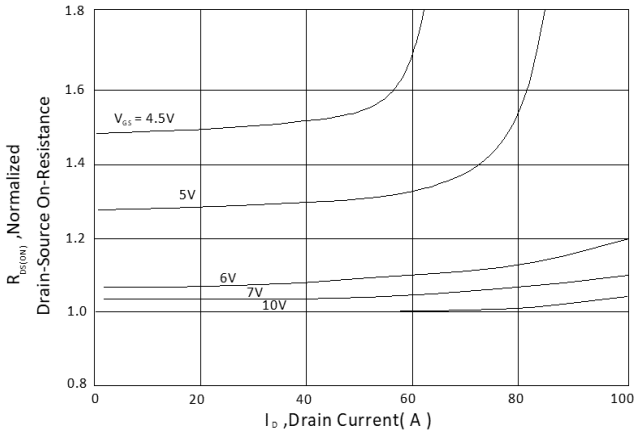


Fig.2 On-Resistance Variation with Drain Current and Gate Voltage

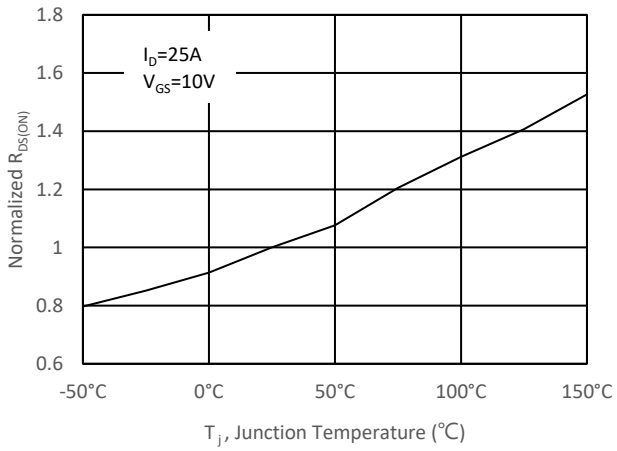


Fig.3 Normalized On-Resistance v.s. Junction Temperature

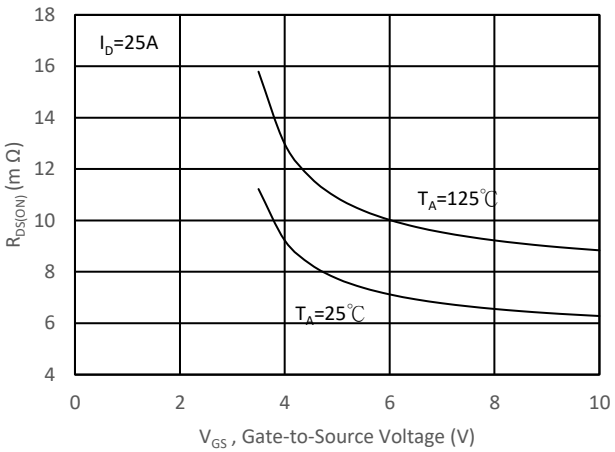


Fig.4 On-Resistance v.s. Gate Voltage

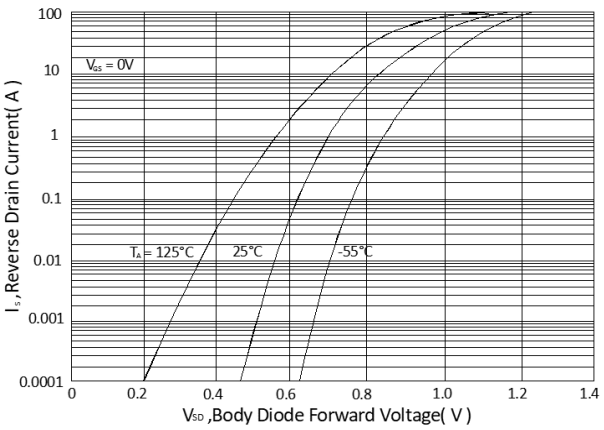


Fig.5 Forward Characteristic of Reverse Diode

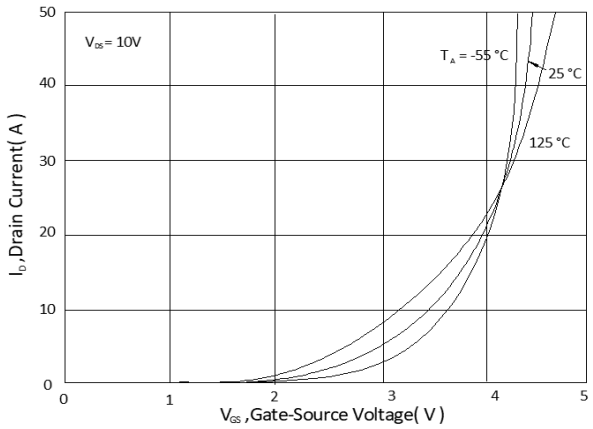


Fig.6 Transfer Characteristics

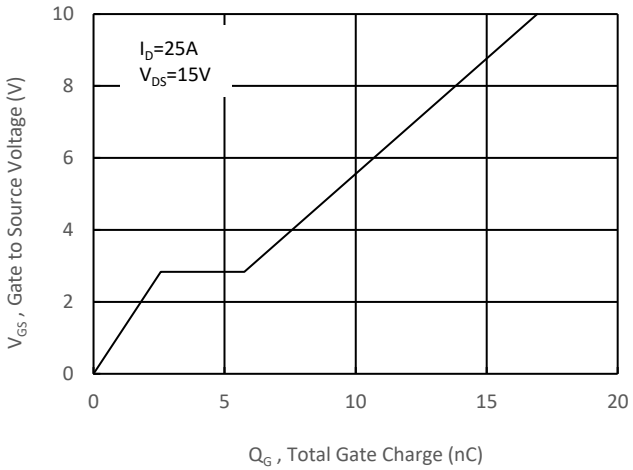


Fig.7 Gate Charge Characteristics

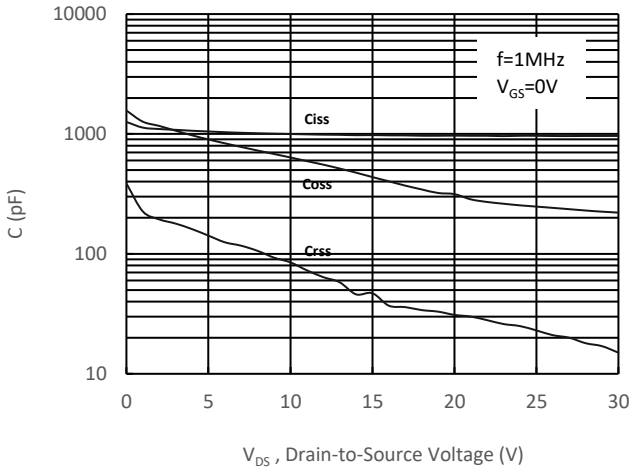


Fig.8 Typical Capacitance Characteristics

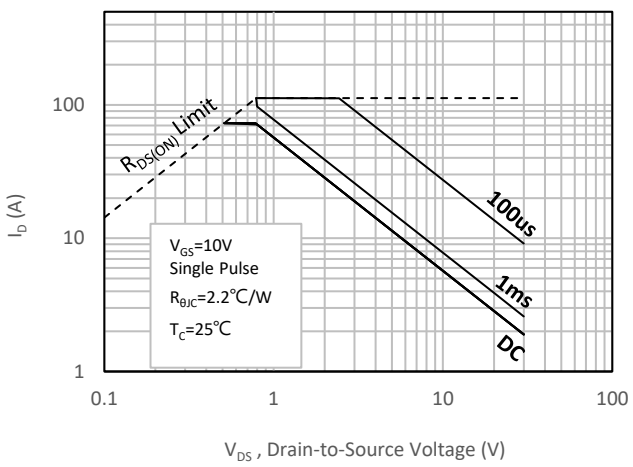


Fig 9. Maximum Safe Operating Area

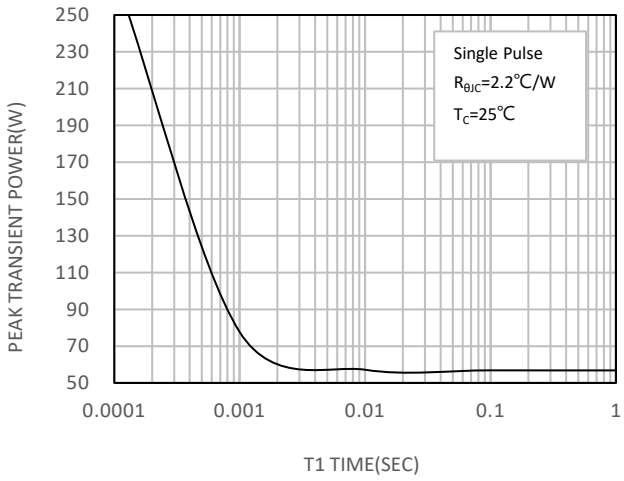


Fig 10. Single Pulse Maximum Power Dissipation

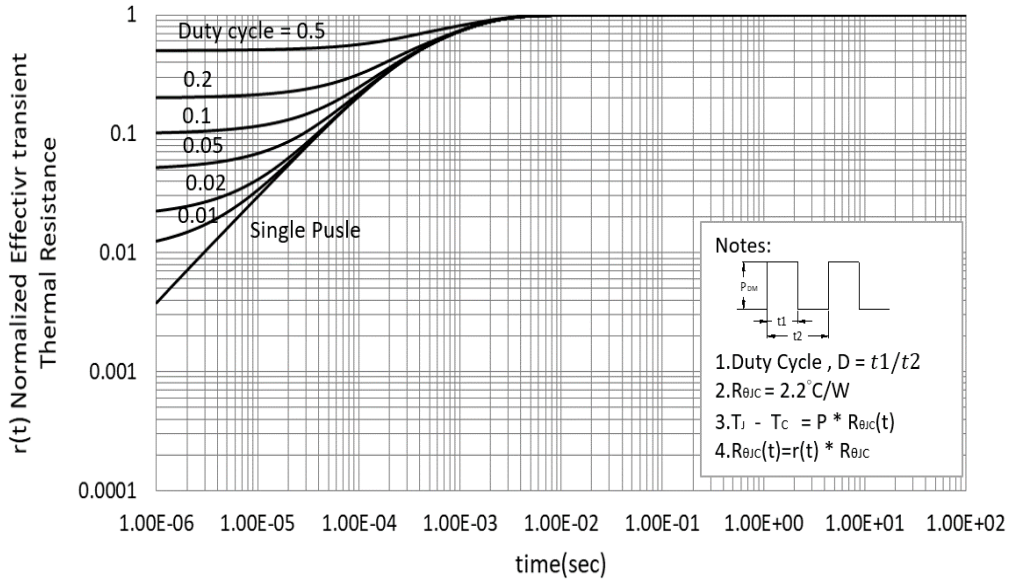


Fig 11. Effective Transient Thermal Impedance

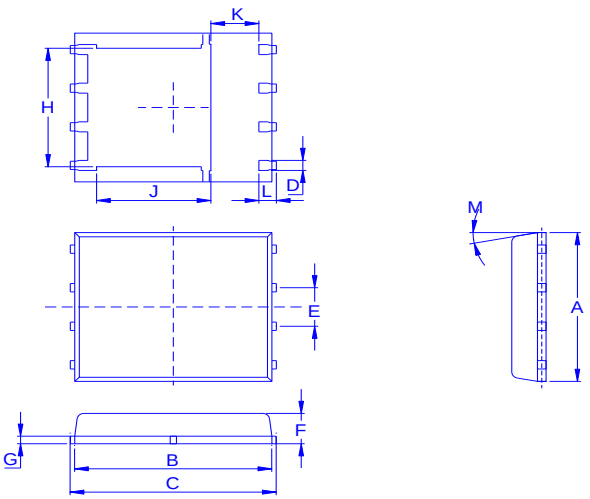
Ordering & Marking Information:

Device Name: EMB07N03HS for EDFN 5x6

B07N03S: Device Name

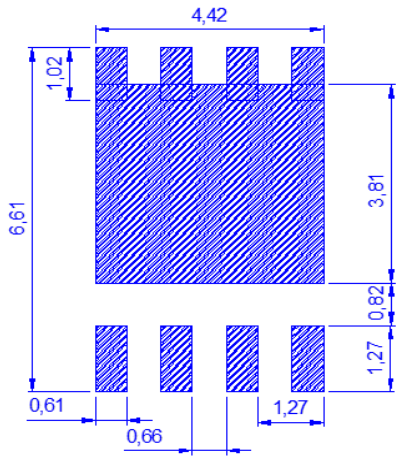
ABCDEFG: Date Code
A: Assembly House
B: Year(A:2008 B:2009 C:2010….)
C: Month(A:01 B:02 C:03 D:04 E:05 F:06 G:07 H:08 I:09 J:10 K:11 L:12)
DEFG: Serial No.

Outline Drawing

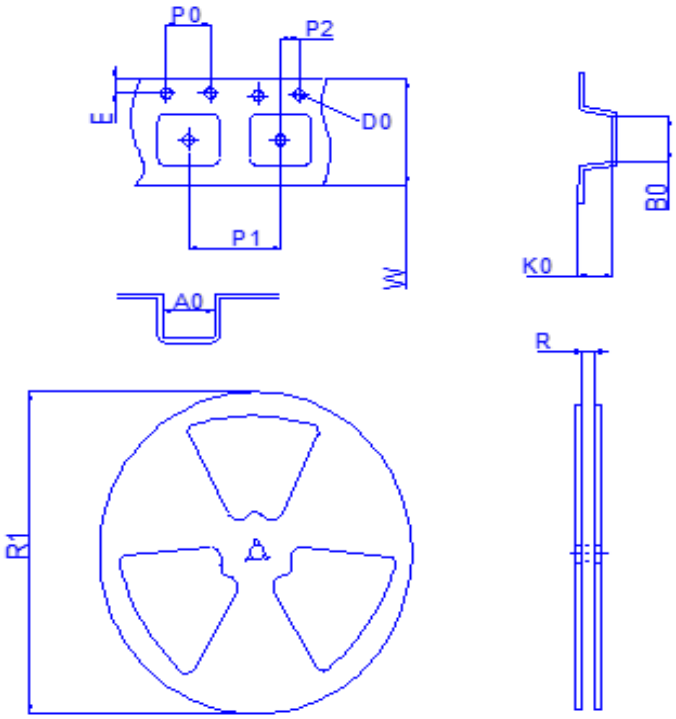


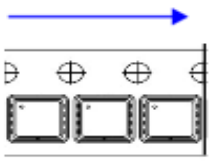
Dimension	A	B	C	D	E	F	G	H	J	K	L	M
Min.	4.8	5.55	5.9	0.3	1.17	0.85	0.15	3.61	3.18	1	0.38	0°
Typ.	4.9	5.7	6	0.4	1.27	0.95	0.2	3.87	3.44	1.2	0.4	
Max.	5.4	5.85	6.15	0.51	1.37	1.17	0.34	4.31	3.78	1.39	0.71	12°

Footprint



◆ **Tape&Reel Information:2500pcs/Reel**
(Dimension in millimeter)



Package	EDFN5X6
Reel	13"
Device orientation	FEED DIRECTION 

Dimension in mm

Dimension	Carrier tape									Reel	
	A0	B0	D0	E	K0	P0	P1	P2	W	R	R1
Typ.	6.4	5.3	1.5	1.8	1.6	4	8	2	12	12.4	330
±	0.2	0.2	0.1	0.1	0.6	0.1	0.1	0.1	0.3	2	2